

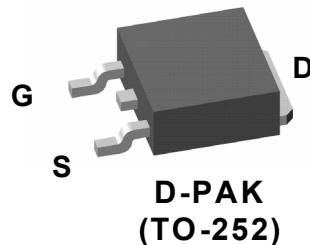
FDD8750

N-Channel PowerTrench® MOSFET

25V, 2.7A, 40mΩ

Features

- Max $r_{DS(on)} = 40\text{m}\Omega$ at $V_{GS} = 10\text{V}$, $I_D = 2.7\text{A}$
- Max $r_{DS(on)} = 60\text{m}\Omega$ at $V_{GS} = 4.5\text{V}$, $I_D = 2.7\text{A}$
- Low gate charge: $Q_{g(10)} = 6\text{nC}(\text{Typ})$
- Low gate resistance
- Avalanche rated and 100% tested
- RoHS Compliant

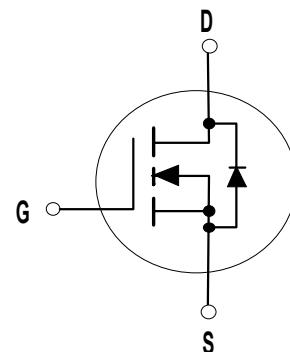


General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $r_{DS(on)}$ and fast switching speed.

Application

- Low current DC-DC switching
- Linear regulation



MOSFET Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Ratings	Units
V_{DS}	Drain to Source Voltage	25	V
V_{GS}	Gate to Source Voltage	± 20	V
I_D	Drain Current -Continuous(Package Limited) $T_C = 25^\circ\text{C}$	2.7	A
	-Continuous(Silicon Limited) $T_C = 25^\circ\text{C}$ (Note 1)	16	
	-Continuous $T_A = 25^\circ\text{C}$ (Note 1a)	6.5	
	-Pulsed	14	
E_{AS}	Drain-Source Avalanche Energy	(Note 3)	mJ
P_D	Power Dissipation $T_C = 25^\circ\text{C}$	18	W
	Power Dissipation (Note 1a)	3.7	
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +175	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	8	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	40	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD8750	FDD8750	D-PAK(TO-252)	13"	12mm	2500 units

Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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Off Characteristics

BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	25			V
$\frac{\Delta \text{BV}_{\text{DSS}}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$, referenced to 25°C		18		$\text{mV}/^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$ $T_J = 150^\circ\text{C}$			1	μA
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$			250	nA
					± 100	

On Characteristics (Note 2)

$V_{GS(\text{th})}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	1.2	2.0	2.5	V
$\frac{\Delta V_{GS(\text{th})}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$, referenced to 25°C		-5		$\text{mV}/^\circ\text{C}$
$r_{DS(\text{on})}$	Static Drain to Source On Resistance	$V_{GS} = 10\text{V}, I_D = 2.7\text{A}$		28	40	$\text{m}\Omega$
		$V_{GS} = 4.5\text{V}, I_D = 2.7\text{A}$		39	60	
		$V_{GS} = 10\text{V}, I_D = 2.7\text{A}, T_J = 150^\circ\text{C}$		44	63	

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS} = 13\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$		320	425	pF
C_{oss}	Output Capacitance			80	110	pF
C_{rss}	Reverse Transfer Capacitance			50	75	pF
R_g	Gate Resistance	$f = 1\text{MHz}$		1.8		Ω

Switching Characteristics

$t_{d(\text{on})}$	Turn-On Delay Time	$V_{DD} = 13\text{V}, I_D = 2.7\text{A}$ $V_{GS} = 10\text{V}, R_{\text{GEN}} = 6\Omega$		3	10	ns
t_r	Rise Time			12	22	ns
$t_{d(\text{off})}$	Turn-Off Delay Time			8	16	ns
t_f	Fall Time			5	10	ns
Q_g	Total Gate Charge	$V_{GS} = 0\text{V} \text{ to } 10\text{V}$ $V_{GS} = 0\text{V} \text{ to } 5\text{V}$ $V_{DD} = 13\text{V}$ $I_D = 2.7\text{A}$		6	9	nC
$Q_{g(5)}$	Total Gate Charge			3.4	5	nC
Q_{gs}	Gate to Source Gate Charge			1.1		nC
Q_{gd}	Gate to Drain "Miller" Charge			1.2		nC

Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0\text{V}, I_S = 2.7\text{A}$ (Note 2)		0.8	1.6	V
t_{rr}	Reverse Recovery Time	$I_F = 2.7\text{A}, di/dt = 100\text{A}/\mu\text{s}$		16	24	ns
Q_{rr}	Reverse Recovery Charge				7	11

Notes:

1: R_{QJA} is the sum of the junction-to-case and case-to- ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{QJC} is guaranteed by design while R_{QJA} is determined by the user's board design.

a. $40^\circ\text{C}/\text{W}$ when mounted on a 1 in^2 pad of 2 oz copper;
b. $96^\circ\text{C}/\text{W}$ when mounted on a minimum pad.

2: Pulse Test: Pulse Width $< 300\mu\text{s}$, Duty cycle $< 2.0\%$.

3: Starting $T_J = 25^\circ\text{C}$, $L = 3\text{mH}$, $I_{AS} = 3.6\text{A}$, $V_{DD} = 25\text{V}$, $V_{GS} = 10\text{V}$.

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

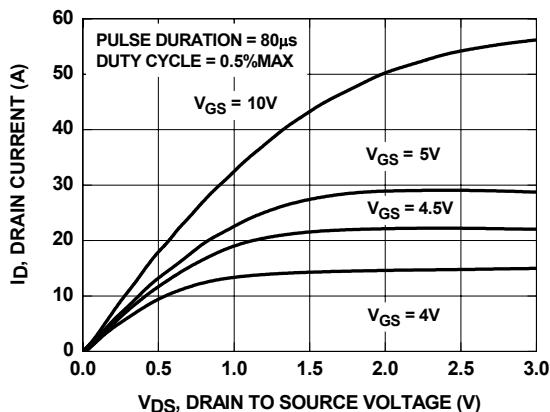


Figure 1. On Region Characteristics

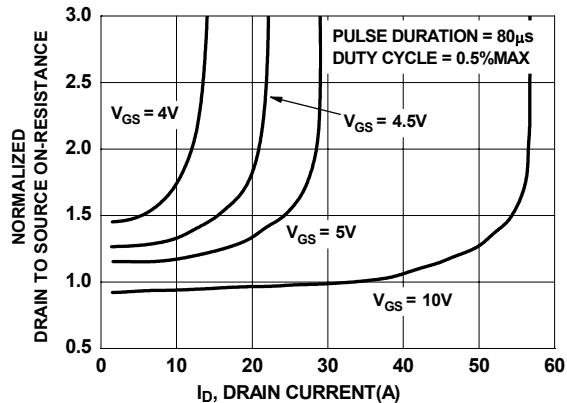


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

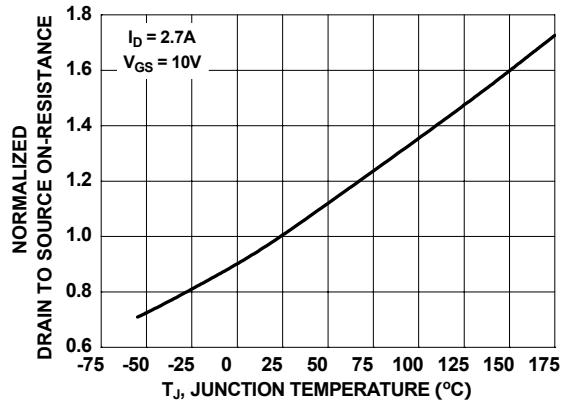


Figure 3. Normalized On Resistance vs Junction Temperature

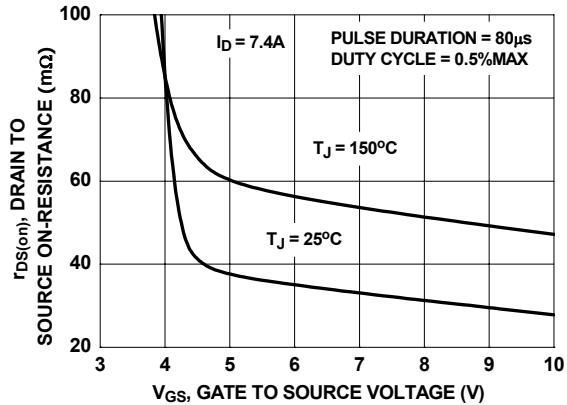


Figure 4. On-Resistance vs Gate to Source Voltage

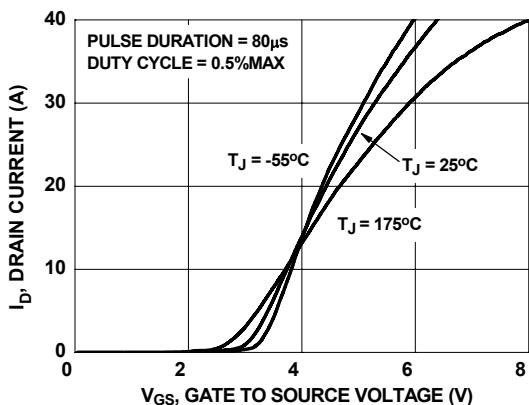


Figure 5. Transfer Characteristics

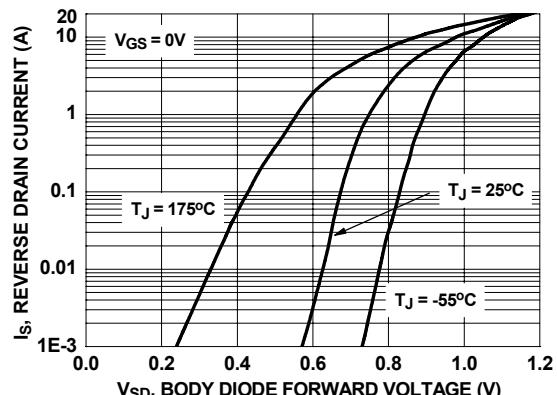


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

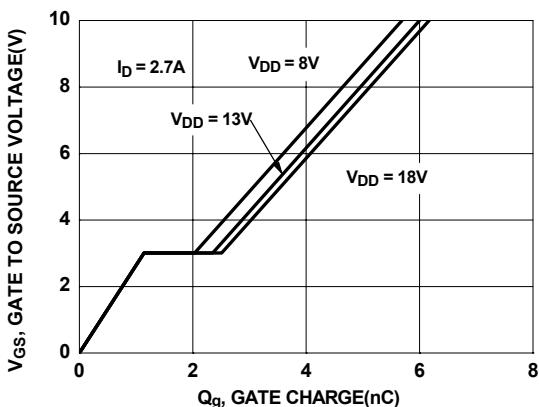


Figure 7. Gate Charge Characteristics

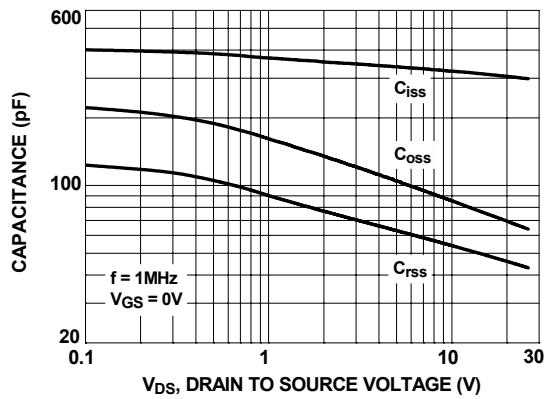


Figure 8. Capacitance vs Drain to Source Voltage

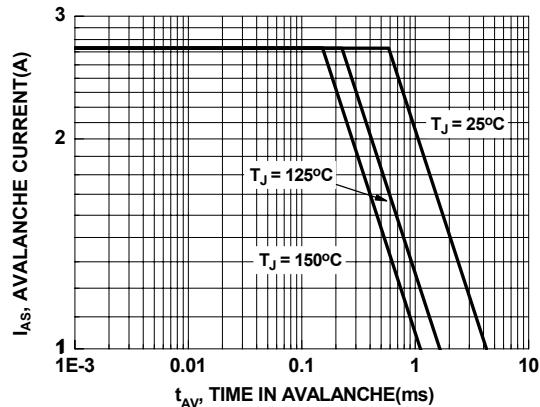


Figure 9. Unclamped Inductive Switching Capability

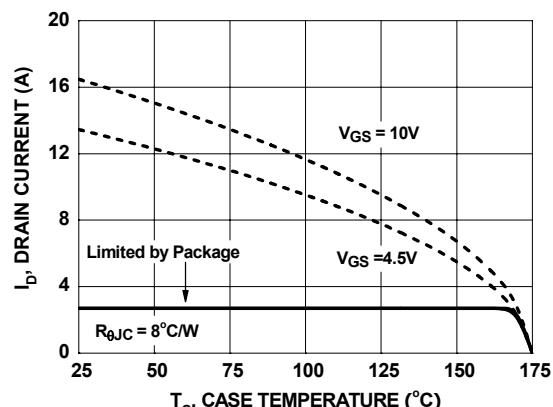


Figure 10. Maximum Continuous Drain Current vs Case Temperature

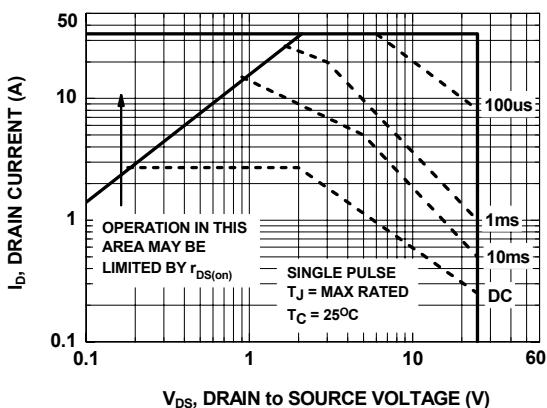


Figure 11. Forward Bias Safe Operating Area

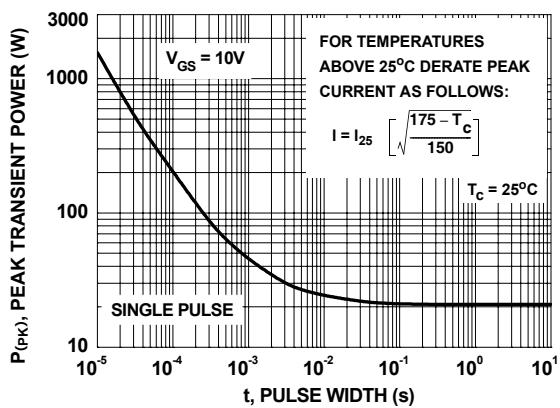


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

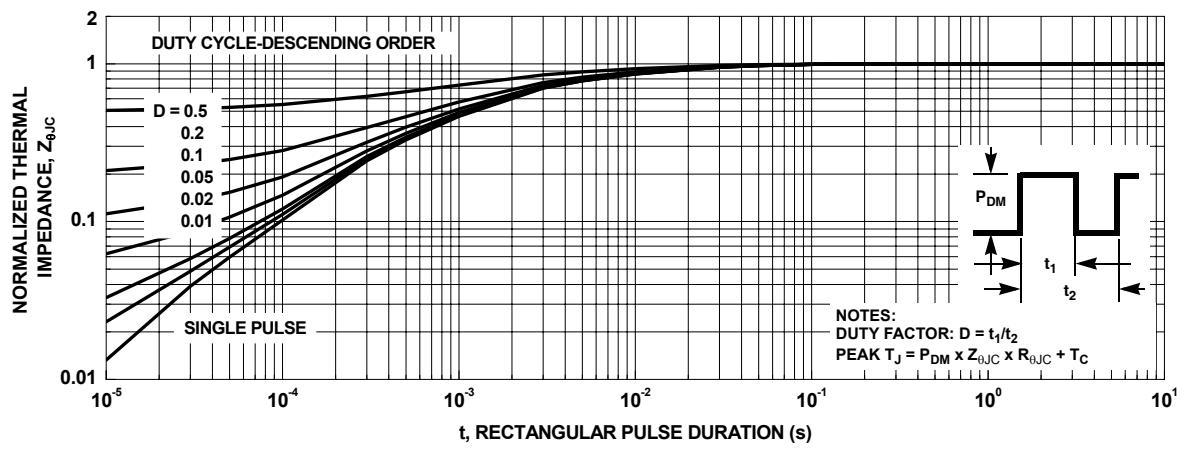


Figure 13. Transient Thermal Response Curve

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